

<b>Notice of References Cited</b>	Application/Control No. 10/083,773		Applicant(s)/Patent Under Reexamination WELSH ET AL.	
	Examiner Jason R. Kurr		Art Unit 2615	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,627,896	05-1997	Southward et al.	381/71.11
*	B	US-5,629,986	05-1997	Shoureshi, Rahmat	381/71.12
*	C	US-5,845,236	12-1998	Jolly et al.	702/195
*	D	US-6,772,074 B2	08-2004	Millott et al.	702/56
*	E	US-6,856,920 B2	02-2005	Millott et al.	702/56
*	F	US-7,003,380 B2	02-2006	MacMartin et al.	700/280
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Break Nyquist Criterion Using Undersampling Technique, Q2 2005 issue of Instrumentation Newsletter, National Instruments, <a href="http://zone.ni.com/devzone/cda/tut/p/id/3915">http://zone.ni.com/devzone/cda/tut/p/id/3915</a>
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.